



BSI Standards Publication

**Microbeam analysis — Analytical electron microscopy
— Method for the determination of interface position
in the cross-sectional image of the layered materials**

National foreword

This British Standard is the UK implementation of ISO 20263:2017.

The UK participation in its preparation was entrusted to Technical Committee CII/9, Microbeam analysis.

A list of organizations represented on this committee can be obtained on request to its secretary.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

© The British Standards Institution 2017
Published by BSI Standards Limited 2017

ISBN 978 0 580 89345 2

ICS 37.020; 71.040.50

Compliance with a British Standard cannot confer immunity from legal obligations.

This British Standard was published under the authority of the Standards Policy and Strategy Committee on 31 December 2017.

Amendments/corrigenda issued since publication

Date	Text affected
------	---------------
